## Notice of References Cited Application/Control No. 10/672,332 Examiner Raj Jain Applicant(s)/Patent Under Reexamination VEDDER, MARK Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,970,714	11-1990	Chen et al.	370/216
*	В	US-5,115,431	05-1992	Williams et al.	370/394
*	С	US-6,404,804	06-2002	Mannering et al.	375/222
	D	US-			
	Е	US-			_
	F	US-			7
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	x						

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